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## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Sheet 1 of 1 Attorney Docket Number 42P

Co	mplete if Known
Application Number	10/666,662
Filing Date	September 18, 2003
First Named Inventor	Vikas C. Raykar
Art Unit	1775 755
Examiner Name .	Not Yet Assigned Jay
Attorney Docket Number	42P17496

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.'	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
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Examiner Signature	GAN	sme	an on	nd	Date Considered	4	23	05	
	I If reference consider		tion is in conformance wi	h MPEP	609. Oraw line thro	ugh citation if not in conto	rrance and no	t considered. In	ctude

'Applicant's unique citation designation number. 'Applicant is to place a check mark here if English language Translation is attached.

Based on PTC/SB/08B (08-03) as modified by Blakely, Sciokoff, Taylor & Zafman (Wr) 08/11/2003. Send To: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450